



ESD



TVS



MOS



LDO



Diode



Sensor



DC-DC

Product Specification

▶ Domestic Part Number	IRF7476
▶ Overseas Part Number	IRF7476
▶ Equivalent Part Number	IRF7476

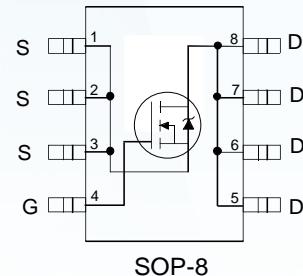


Benefits

- $V_{DS} (V) = 12V$
- $R_{DS(ON)} < 8m\Omega$ ($V_{GS} = 4.5V$)
- $R_{DS(ON)} < 30m\Omega$ ($V_{GS} = 2.8V$)

Applications

- High Frequency 3.3V and 5V input Point-of-Load Synchronous Buck Converters for Netcom and Computing Applications.
- Power Management for Netcom, Computing and Portable Applications.
- Lead-Free



Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
V_{DS}	Drain-Source Voltage	12	V
V_{GS}	Gate-to-Source Voltage	± 12	V
$I_D @ T_A = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	15	A
$I_D @ T_A = 70^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	12	
I_{DM}	Pulsed Drain Current①	120	
$P_D @ T_A = 25^\circ C$	Maximum Power Dissipation④	2.5	W
$P_D @ T_A = 70^\circ C$	Maximum Power Dissipation④	1.6	W
	Linear Derating Factor	0.02	W/ $^\circ C$
T_J, T_{STG}	Junction and Storage Temperature Range	-55 to + 150	$^\circ C$

Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JL}$	Junction-to-Drain Lead		20	
$R_{\theta JA}$	Junction-to-Ambient ④		50	$^\circ C/W$

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25^\circ C$, $L = 2.3mH$
 $R_G = 25\Omega$, $I_{AS} = 12A$.
- ③ Pulse width $\leq 400\mu s$; duty cycle
- ④ When mounted on 1 inch square copper board.

Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	12			V	$V_{GS} = 0V, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient		0.014		V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	6.0	8.0		$\text{m}\Omega$	$V_{GS} = 4.5\text{V}, I_D = 15\text{A}$ ③
			12	30		$V_{GS} = 2.8\text{V}, I_D = 12\text{A}$ ③
$V_{GS(\text{th})}$	Gate Threshold Voltage	0.6		1.9	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
I_{DSS}	Drain-to-Source Leakage Current		100		μA	$V_{DS} = 9.6\text{V}, V_{GS} = 0V$
			250			$V_{DS} = 9.6\text{V}, V_{GS} = 0V, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage		200		nA	$V_{GS} = 12\text{V}$
	Gate-to-Source Reverse Leakage		-200			$V_{GS} = -12\text{V}$

Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

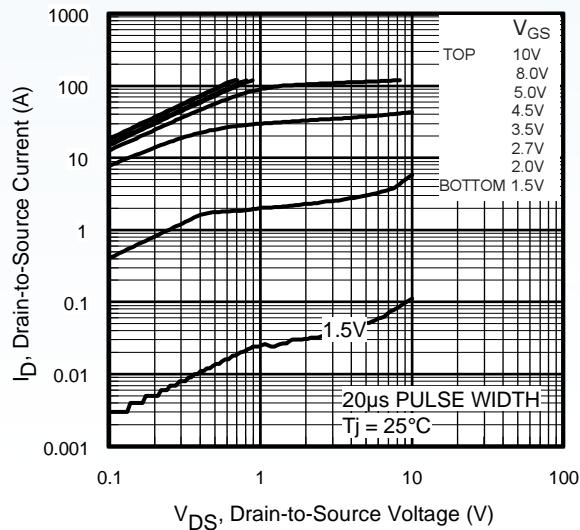
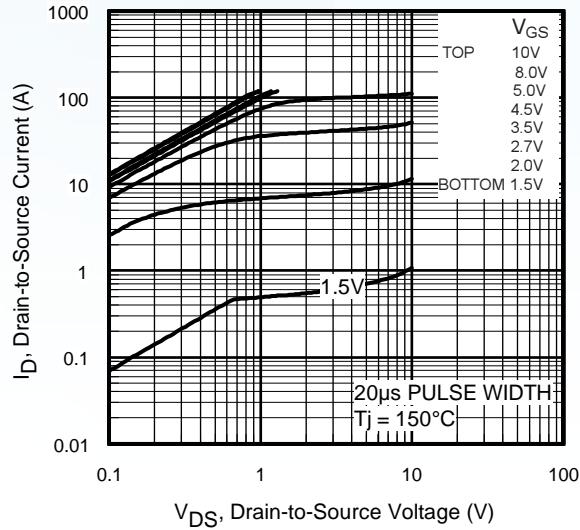
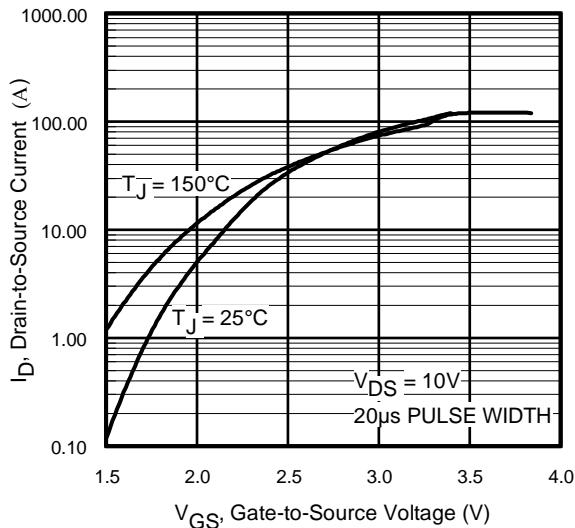
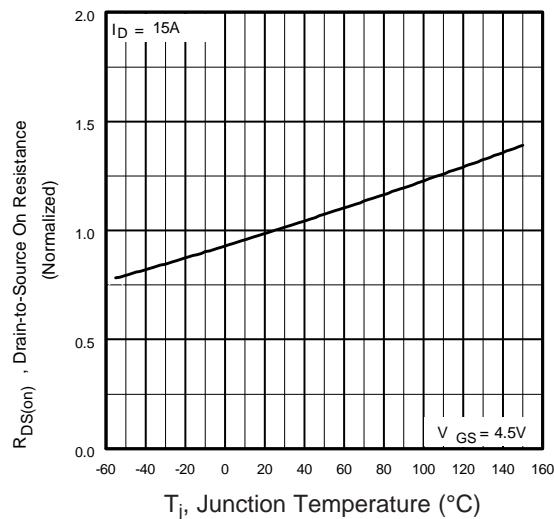
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
g_{fs}	Forward Transconductance	31			S	$V_{DS} = 6.0\text{V}, I_D = 12\text{A}$
Q_g	Total Gate Charge		26	40		$I_D = 12\text{A}$
Q_{gs}	Gate-to-Source Charge		4.6		nC	$V_{DS} = 10\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge		11			$V_{GS} = 4.5\text{V}$
Q_{oss}	Output Gate Charge		17			$V_{GS} = 0\text{V}, V_{DS} = 5.0\text{V}$
$t_{d(on)}$	Turn-On Delay Time	11				$V_{DD} = 6.0\text{V}$
t_r	Rise Time		29		ns	$I_D = 12\text{A}$
$t_{d(off)}$	Turn-Off Delay Time		19			$R_G = 1.8\Omega$
t_f	Fall Time		8.3			$V_{GS} = 4.5\text{V}$ ③
C_{iss}	Input Capacitance	2550				$V_{GS} = 0\text{V}$
C_{oss}	Output Capacitance	2190				$V_{DS} = 6.0\text{V}$
C_{rss}	Reverse Transfer Capacitance	450			pF	$f = 1.0\text{MHz}$

Avalanche Characteristics

Symbol	Parameter	Typ.	Max.	Units
E_{AS}	Single Pulse Avalanche Energy②		160	mJ
I_{AR}	Avalanche Current①		12	A

Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)			2.5		MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①			120	A	
V_{SD}	Diode Forward Voltage	0.87	1.2		V	$T_J = 25^\circ\text{C}, I_S = 12\text{A}, V_{GS} = 0\text{V}$ ③
			0.73			$T_J = 125^\circ\text{C}, I_S = 12\text{A}, V_{GS} = 0\text{V}$ ③
t_{rr}	Reverse Recovery Time	55	82	ns		$T_J = 25^\circ\text{C}, I_F = 12\text{A}, V_R=12\text{V}$
Q_{rr}	Reverse Recovery Charge	59	89	nC		$dI/dt = 100\text{A}/\mu\text{s}$ ③
t_{rr}	Reverse Recovery Time	54	81	ns		$T_J = 125^\circ\text{C}, I_F = 12\text{A}, V_R=12\text{V}$
Q_{rr}	Reverse Recovery Charge	60	90	nC		$dI/dt = 100\text{A}/\mu\text{s}$ ③

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)**Fig 1.** Typical Output Characteristics**Fig 2.** Typical Output Characteristics**Fig 3.** Typical Transfer Characteristics**Fig 4.** Normalized On-Resistance Vs. Temperature

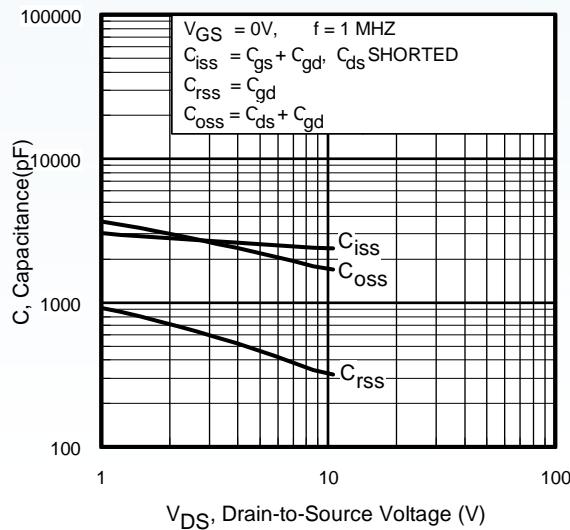
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

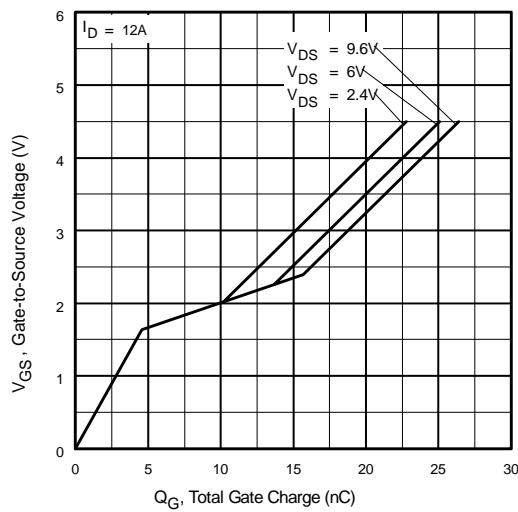


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

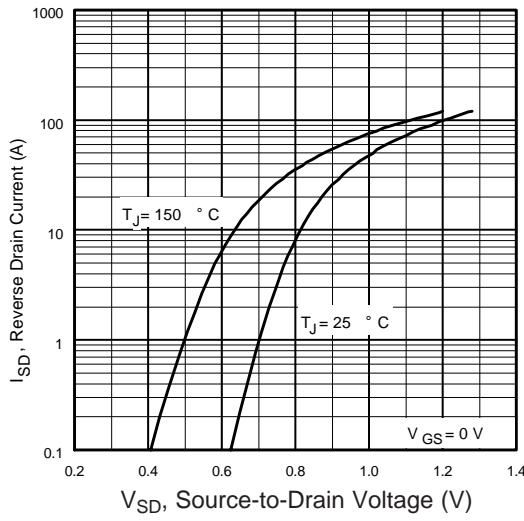


Fig 7. Typical Source-Drain Diode
Forward Voltage

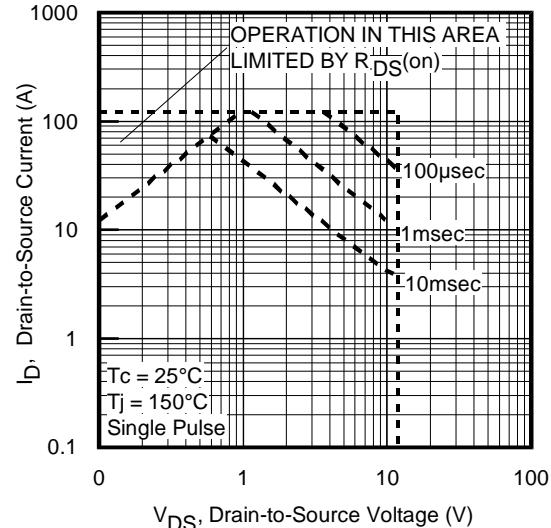


Fig 8. Maximum Safe Operating Area

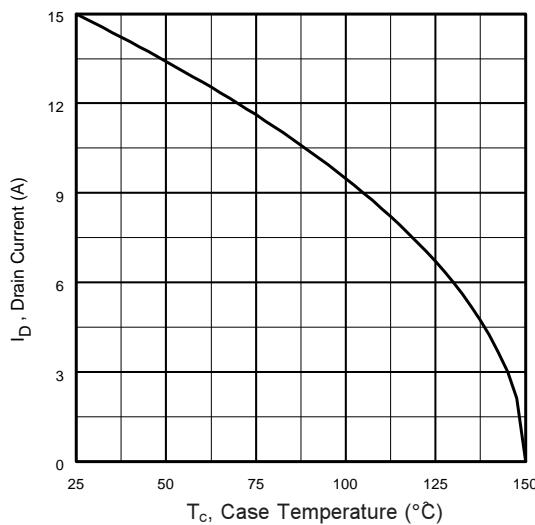


Fig 9. Maximum Drain Current Vs. Case Temperature

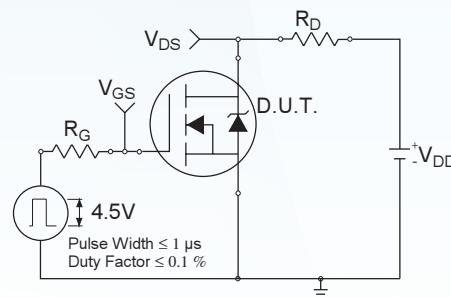


Fig 10a. Switching Time Test Circuit

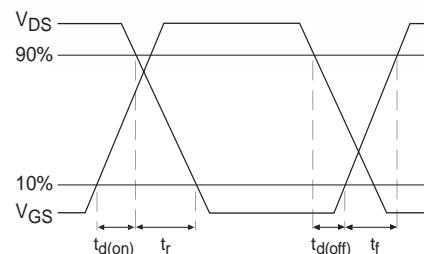


Fig 10b. Switching Time Waveforms

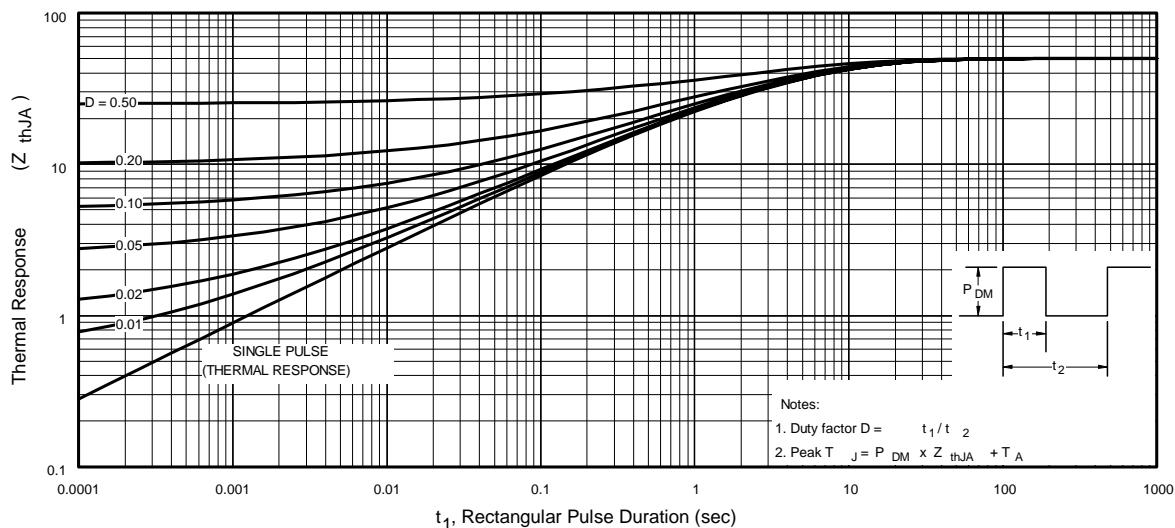
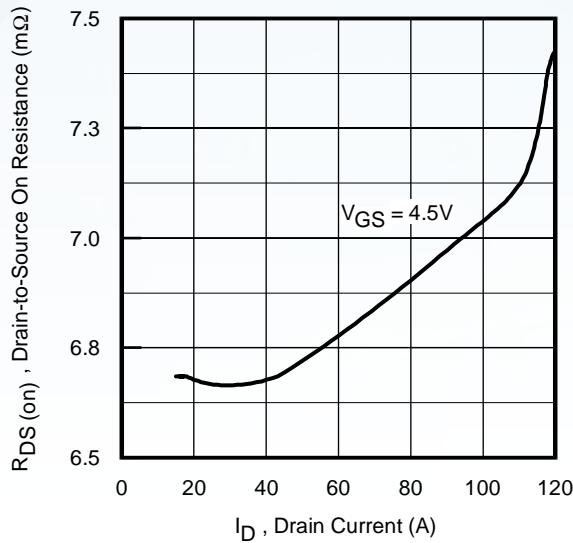
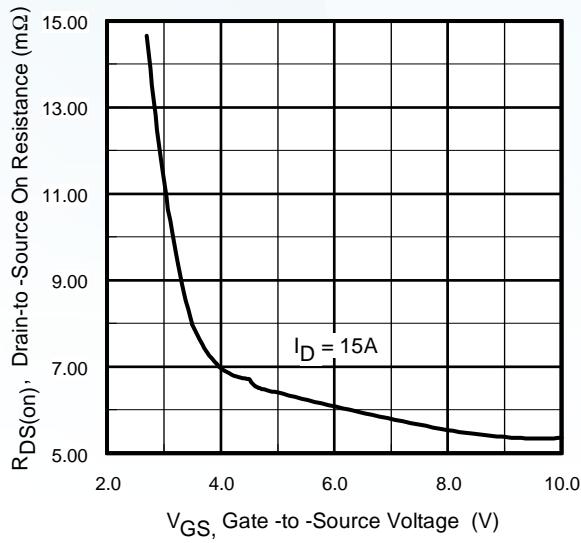
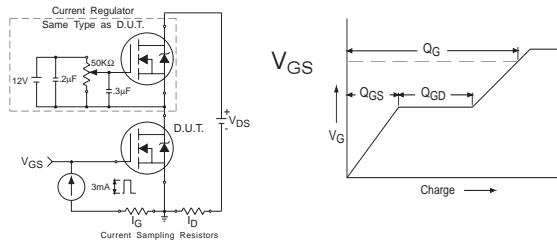
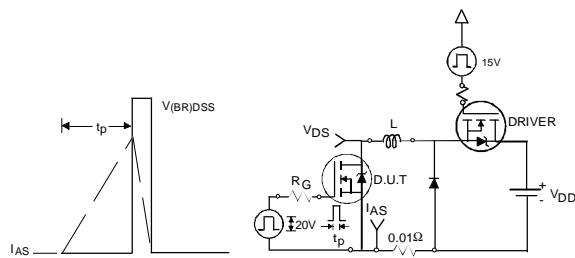
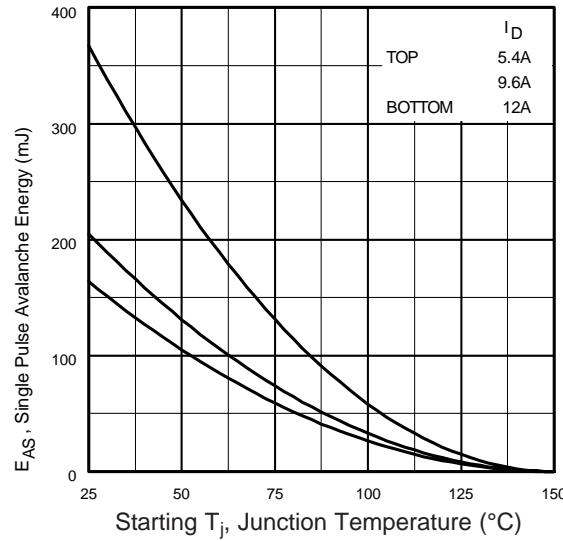
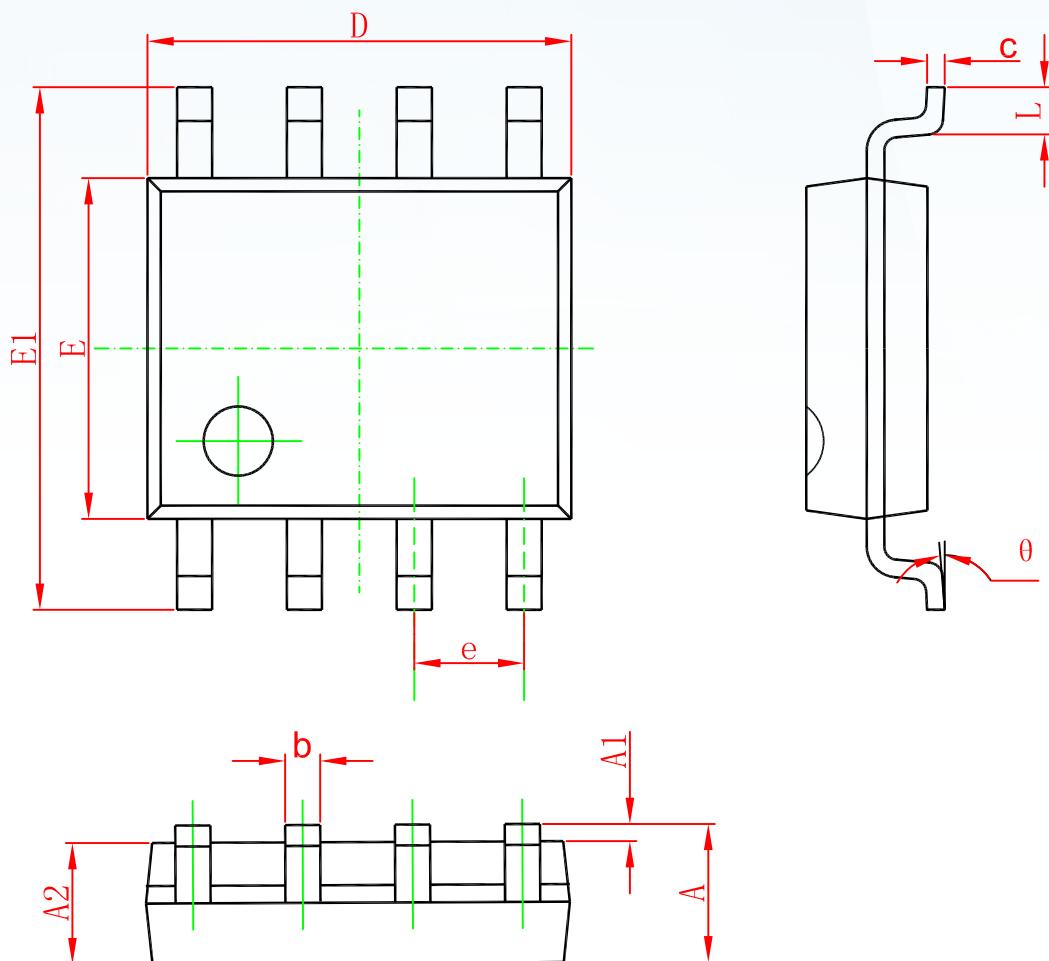


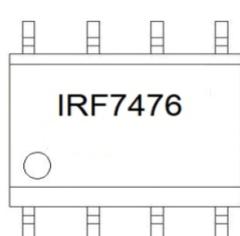
Fig 10. Maximum Effective Transient Thermal Impedance, Junction-to-Case

**Fig 12.** On-Resistance Vs. Drain Current**Fig 13.** On-Resistance Vs. Gate Voltage**Fig 13a&b.** Basic Gate Charge Test Circuit and Waveform**Fig 14a&b.** Unclamped Inductive Test circuit and Waveforms**Fig 14c.** Maximum Avalanche Energy Vs. Drain Current

SOP-8

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

Marking



Ordering information

Order code	Package	Baseqty	Deliverymode
IRF7476	SOP-8	3000	Tape and reel

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